

### Fast Switching Emitter Controlled Diode



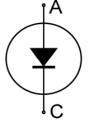


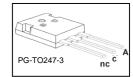




### Features:

- 600V Emitter Controlled technology
- Fast recovery
- Soft switching
- Low reverse recovery charge
- Low forward voltage
- 175°C junction operating temperature
- Easy paralleling
- Pb-free lead plating; RoHS compliant
- Complete product spectrum and PSpice Models: http://www.infineon.com





### **Applications:**

- Welding
- Motor drives

Туре	$V_{RRM}$	I <sub>F</sub>	V <sub>F,Tj=25°C</sub>	$T_{\rm j,max}$	Marking	Package
IDW100E60	600V	100A	1.65V	175°C	D100E60	PG-TO247-3

### **Maximum Ratings**

Parameter	Symbol	Value	Unit	
Repetitive peak reverse voltage	$V_{RRM}$	600	V	
Continuous forward current				
$T_{\rm C}$ = 25°C	,	150		
$T_{\rm C} = 90^{\circ}{\rm C}$	I <sub>F</sub>	104	Α	
$T_{\rm C}$ = 100°C		96		
Surge non repetitive forward current	,	400		
$T_{\rm C}$ = 25°C, $t_{\rm p}$ = 10 ms, sine halfwave	I <sub>FSM</sub>	400	Α	
Maximum repetitive forward current	current		Δ.	
$T_{\rm C}$ = 25°C, $t_{\rm p}$ limited by $t_{\rm j,max}$ , $D$ = 0.5	I <sub>FRM</sub>	300	Α	
Power dissipation				
$T_{\rm C} = 25^{\circ}{\rm C}$		375	107	
$T_{\rm C} = 90^{\circ}{\rm C}$	$P_{tot}$	212	W	
$T_{\rm C} = 100^{\circ}{\rm C}$		198		
Operating junction temperature	T <sub>j</sub>	-40+175		
Storage temperature	$T_{ m stg}$	-55+150	°C	
Soldering temperature 1.6mm (0.063 in.) from case for 10 s	Ts	260		





### **Thermal Resistance**

Parameter	Symbol	Conditions	Max. Value	Unit
Characteristic				
Thermal resistance,	$R_{thJC}$		0.40	K/W
junction – case				
Thermal resistance,	$R_{thJA}$		40	
junction – ambient				

## **Electrical Characteristic,** at $T_j$ = 25 °C, unless otherwise specified

Devenuetos	Symbol Conditions Value		Unit			
Parameter	Symbol	Conditions	min.	typ.	max.	Unit
Static Characteristic						
Collector-emitter breakdown voltage	$V_{RRM}$	$I_R=0.25$ mA	600	-	-	V
Diode forward voltage	V <sub>F</sub>	I <sub>F</sub> =100A				1
		<i>T</i> <sub>j</sub> =25°C	-	1.65	2.0	
		<i>T</i> <sub>j</sub> =175°C	-	1.65	-	
Reverse leakage current	$I_{R}$	V <sub>R</sub> =600V				μΑ
		<i>T</i> <sub>j</sub> =25°C	-	-	40	
		<i>T</i> <sub>j</sub> =175°C	-	-	3300	
						•
<b>Dynamic Electrical Characteristics</b>						
Diode reverse recovery time	$t_{rr}$	<i>T</i> <sub>j</sub> =25°C	-	120	-	ns
Diode reverse recovery charge	Q <sub>rr</sub>	$V_{R} = 400 V$ ,	-	3.6	-	μC
Diode peak reverse recovery current	I <sub>rr</sub>	$I_{\rm F} = 100  \rm A$	-	49.5	-	Α
Diode peak rate of fall of reverse recovery current during $t_b$	dI <sub>rr</sub> /dt	$dI_{\text{F}}/dt$ =1200A/ $\mu$ s	-	750	-	A/µs
	•	1	u.		•	- !!
Diode reverse recovery time	t <sub>rr</sub>	T <sub>j</sub> =125°C	-	168	-	ns
Diode reverse recovery charge	Q <sub>rrm</sub>	$V_{R} = 400 V$ ,	-	5.8	-	μC
Diode peak reverse recovery current	I <sub>rr</sub>	$I_{\rm F} = 100  \rm A$	-	61.6	-	Α
Diode peak rate of fall of reverse recovery current during $t_b$	dI <sub>rr</sub> /dt	$dI_{\text{F}}/dt$ =1200A/ $\mu$ s	-	705	-	A/µs
		1	II.			_1
Diode reverse recovery time	$t_{rr}$	T <sub>i</sub> =175°C	-	200	-	ns
Diode reverse recovery charge	Q <sub>rrm</sub>	V <sub>R</sub> =400V,	-	7.8	-	μC
Diode peak reverse recovery current	I <sub>rr</sub>	$I_{\rm F} = 100  \rm A$	-	67.0	-	Α
Diode peak rate of fall of reverse recovery current during $t_{\rm b}$	dI <sub>rr</sub> /dt	$dI_{\rm F}/dt$ =1200A/ $\mu$ s	-	650	-	A/µs



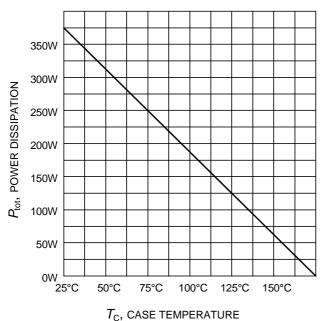


Figure 1. Power dissipation as a function of case temperature  $(T_i \le 175^{\circ}\text{C})$ 

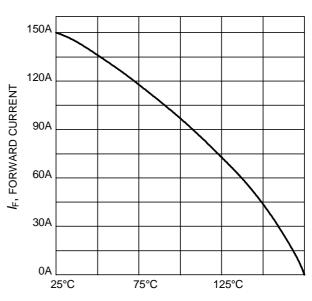


Figure 2. Diode forward current as a function of case temperature  $(T_i \le 175^{\circ}C)$ 

 $T_{\rm C}$ , CASE TEMPERATURE

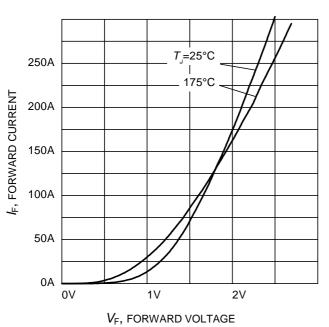


Figure 3. Typical diode forward current as a function of forward voltage

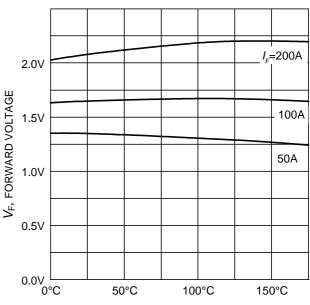


Figure 4. Typical diode forward voltage as a function of junction temperature

 $T_{\rm J}$ , JUNCTION TEMPERATURE





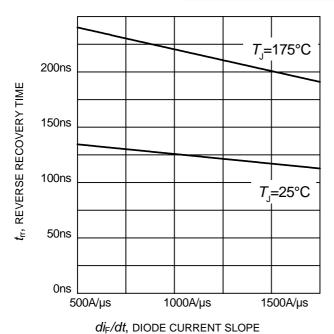
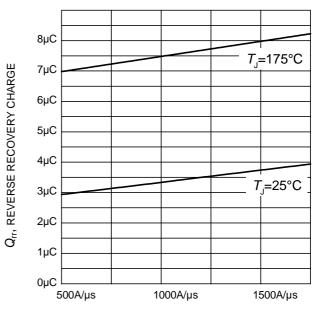


Figure 5. Typical reverse recovery time as a function of diode current slope  $(V_R=400V, I_F=100A, Dynamic test circuit in Figure E)$ 



di<sub>F</sub>/dt, DIODE CURRENT SLOPE

Figure 6. Typical reverse recovery charge as a function of diode current slope  $(V_R = 400V, I_F = 100A, Dynamic test circuit in Figure E)$ 

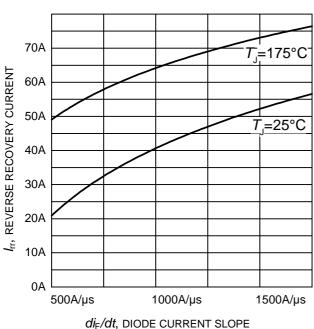
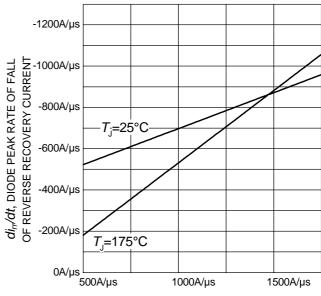


Figure 7. Typical reverse recovery current as a function of diode current slope

( $V_R = 400V$ ,  $I_F = 100A$ , Dynamic test circuit in Figure E)



 $di_{\rm F}/dt$ , DIODE CURRENT SLOPE

Figure 8. Typical diode peak rate of fall of reverse recovery current as a function of diode current slope ( $V_R$ =400V,  $I_F$ =100A, Dynamic test circuit in Figure E)



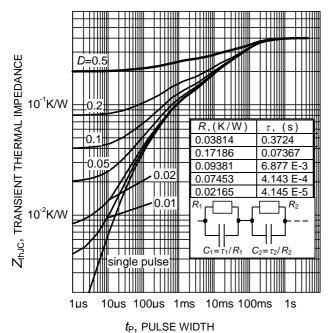
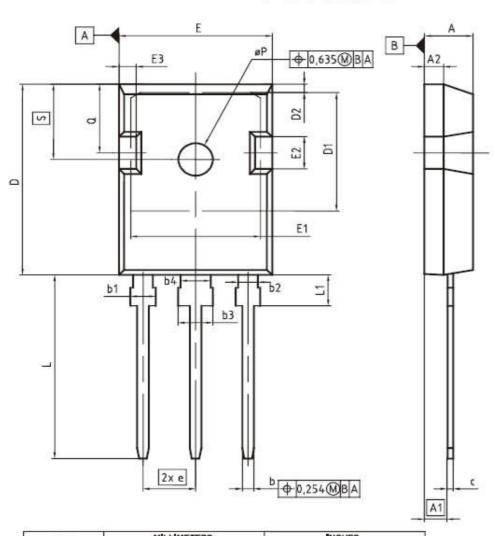


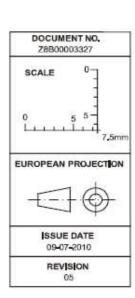
Figure 9. Diode transient thermal impedance as a function of pulse width  $(D=t_{\mathbb{P}}/T)$ 



# PG-TO247-3



DBM	MILLIM	ETERS	NCHES		
DEM	MIN	MAX	MIN	MAX	
A	4,83	5,21	0.190	0,205	
A1	2,27	2,54	0.089	0,100	
A2	1.85	2,16	0.073	0,085	
ь	1.07	1,33	0,042	0,052	
b1	1.90	2.41	0.075	0,095	
b2	1.90	2.16	0,075	0.085	
b3	2,87	3.38	0.113	0.133	
b4	2,87	3.13	0.113	0.123	
c	0,55	0.68	0,022	0,027	
D	20,80	21,10	0.819	0.831	
D1	16,25	17.65	0.640	0,695	
D2	0.95	1.35	0.037	0,053	
E	15.70	16.13	0,618	0,635	
E1	13.10	14.15	0,516	0,557	
E2	3,68	5.10	0.145	0,201	
E3	1.00	2.60	0.039	0.102	
e	5.	44 (BSC)	0.214 (BSC)		
N		3		3	
L	19,80	20,32	0.780	0.800	
L1	4.10	4.47	0.161	0,176	
øΡ	3,50	3,70	0,138	0,146	
Q	5.49	6.00	0.216	0.236	
S	6,04	6,30	0,238	0,248	





Published by Infineon Technologies AG 81726 Munich, Germany © 2013 Infineon Technologies AG All Rights Reserved.

### **Legal Disclaimer**

The information given in this document shall in no event be regarded as a guarantee of conditions or characteristics. With respect to any examples or hints given herein, any typical values stated herein and/or any information regarding the application of the device, Infineon Technologies hereby disclaims any and all warranties and liabilities of any kind, including without limitation, warranties of non-infringement of intellectual property rights of any third party.

#### Information

For further information on technology, delivery terms and conditions and prices, please contact the nearest Infineon Technologies Office (www.infineon.com).

#### Warnings

Due to technical requirements, components may contain dangerous substances. For information on the types in question, please contact the nearest Infineon Technologies Office.

The Infineon Technologies component described in this Data Sheet may be used in life-support devices or systems and/or automotive, aviation and aerospace applications or systems only with the express written approval of Infineon Technologies, if a failure of such components can reasonably be expected to cause the failure of that life-support, automotive, aviation and aerospace device or system or to affect the safety or effectiveness of that device or system. Life support devices or systems are intended to be implanted in the human body or to support and/or maintain and sustain and/or protect human life. If they fail, it is reasonable to assume that the health of the user or other persons may be endangered.

# **Mouser Electronics**

**Authorized Distributor** 

Click to View Pricing, Inventory, Delivery & Lifecycle Information:

Infineon: